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INFORMATION DISCLOSURE  
STATEMENT BY APPLICANT  
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(37 CFR 1.98(b))

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TECHNOLOGY

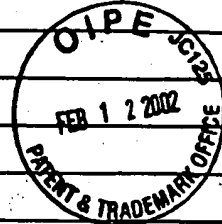
Atty Docket No.: 555255012295

Serial No.: 10/014,940

Applicant: Geyi Wen, et al.

Filing Date: October 26, 2001

Group: 2821



U.S. PATENT DOCUMENTS

Exam. Init.	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date
%%	6 0 3 1 5 0 5	02/29/2000	Qi, et al.	343	795	
%%	5 9 9 0 8 3 8	11/23/1999	Burns, et al.	343	702	

FOREIGN PATENT OR PUBLISHED FOREIGN PATENT APPLICATION

Exam. Init.	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation Yes No
%%	0 8 9 2 4 5 9	01/20/1999	EPO			
%%	0 7 6 5 0 0 1	03/26/1997	EPO			

OTHER DOCUMENTS (Including Author, Title, Date\*\*, Relevant pages, Place of Publication\*\*\*)

%%	PCT International Search Report (Int'l. Appln. No. PCT/CA01/00416 filed March 29, 2001)

Examiner

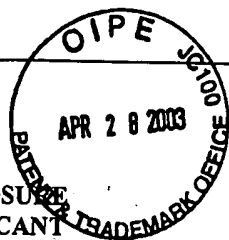
*John Vannucci*

Date Considered

5-12-04

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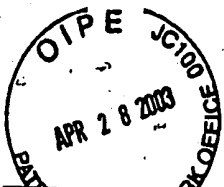
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U.S. PATENT DOCUMENTS

Exam. Init.	Document No.	Date MM/DD/YYYY	Name	Class	Subclass	Filing Date
AA	3 5 2 1 2 8 4	07/21/1970	Shelton Jr. et al.			
AB	3 5 9 9 2 1 4	08/10/1971	Altmayer			
AC	3 6 2 2 8 9 0	11/23/1971	Fujimoto et al.			
AD	3 6 8 3 3 7 6	08/08/1972	Pronovost			
AE	4 0 2 4 5 4 2	05/14/1977	Ikawa et al.			
AF	4 4 7 1 4 9 3	09/11/1984	Schober			
AG	4 5 0 4 8 3 4	03/12/1985	Garay et al.			
AH	4 5 4 3 5 8 1	09/24/1985	Nemet			
AI	4 5 7 1 5 9 5	02/18/1986	Phillips et al.			
AJ	4 5 8 4 7 0 9	04/22/1986	Kneisel et al.			
AK	4 5 9 0 6 1 4	05/20/1980	Erat			
AL	4 7 3 0 1 9 5	03/08/1988	Phillips et al.			
AM	4 8 3 9 6 6 0	06/13/1989	Hadzoglou			
AN	4 8 4 7 6 2 9	07/11/1989	Shimazaki			
AO	4 8 5 7 9 3 9	08/15/1989	Shimazaki			
AP	4 8 9 0 1 1 4	12/26/1989	Egashira			
AQ	4 8 9 4 6 6 3	01/16/1990	Urbish et al.			
AR	4 9 7 5 7 1 1	12/04/1990	Lee			
AS	5 0 3 0 9 6 3	07/09/1991	Tadama			
AT	5 1 3 8 3 2 8	08/11/1992	Zibrik et al.			
AU	5 2 1 4 4 3 4	05/25/1993	Hsu			
AV	5 2 1 8 3 7 0	06/08/1993	Blaese			
AW	5 2 2 7 8 0 4	07/13/1993	Oda			
AX	5 2 4 5 3 5 0	09/14/1993	Sroka			
AY	5 2 5 7 0 3 2	10/26/1993	Diamond et al.			
AZ	5 3 4 7 2 9 1	09/13/1994	Moore			
AAA	5 3 7 3 3 0 0	12/13/1994	Jenness et al.			
ABB	5 4 2 2 6 5 1	06/06/1995	Chang			
ACC	5 4 5 1 9 6 5	09/19/1995	Matsumoto			
ADD	5 4 5 1 9 6 8	09/19/1995	Emery			
AEE	5 4 5 7 4 6 9	10/10/1995	Diamond et al.			
AFF	5 4 9 3 7 0 2	02/20/1996	Crowley et al.			
AGG	5 6 8 4 6 7 2	11/04/1997	Karidis et al.			
AHH	5 7 6 7 8 1 1	06/16/1998	Mandai et al.			
AII	5 8 2 1 9 0 7	10/13/1998	Zhu et al.			



AKK	5	8	4	1	4	0	3	11/24/1998	West				
ALL	5	8	7	2	5	4	6	02/09/1999	Asakura et al.				
AMM	5	9	0	3	2	4	0	02/16/1999	Ihara et al.				
ANN	5	9	6	6	0	9	8	05/11/1999	Kawahata et al.				
AOO	5	9	7	3	6	5	1	10/12/1999	Qi et al.				
APP	5	9	7	7	9	2	0	10/26/1999	Suesada et al.				
AQQ	6	0	2	8	5	6	8	11/02/1999	Hung				
ARR	6	3	2	9	9	5	1	02/22/2000	Asakura et al.				
ASS	6	3	3	7	6	6	7	12/11/2001	Wen et al.				
ATT								01/08/2002	Ayala et al.				

### FOREIGN PATENT OR PUBLISHED FOREIGN PATENT APPLICATION

FOREIGN PATENT OR PUBLISHED FOREIGN PATENT APPLICATION														
Exam. Init.	Document Number								Publication Date of the Grant	Country or Patent Office	Class	Subclass	Translation	
													Yes	No
W ↓		0	5	4	3	6	4	5	05/26/1993	EPO				
		0	5	7	1	1	2	4	11/24/1993	EPO				
		0	8	1	4	5	3	6	12/29/1997	EPO				
		55	1	4	7	8	0	6	11/18/1980	Japan				
		05	0	0	7	1	0	9	01/14/1993	Japan				
		5	1	2	9	8	1	6	05/25/1993	Japan				
		5	2	6	7	9	1	6	10/15/1993	Japan				
		05	3	4	7	5	0	7	12/27/1993	Japan				
		6	2	0	4	9	0	8	07/22/1994	Japan				
		9	6	3	8	8	8	1	12/05/1996	WO				
		9	7	3	3	3	3	8	12/09/1997	WO				
		9	8	1	2	7	7	1	03/26/1998	WO				
		9	9	0	3	1	6	6	01/21/1999	WO				
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		0	0	0	1	0	2	8	01/06/2000	WO				
		0	1	7	8	1	9	2	10/18/2001	WO				
		2	3	3	0	9	5	1	05/05/1999	United Kingdom				

### OTHER DOCUMENTS (Including Author, Title, Date\*\*, Relevant pages, Place of Publication\*\*\*)

W	AAU	Microwave Journal, May 1984, p. 242, advertisement of Solitron/Microwave, XP002032716
	AVV	
Examiner: <i>[Signature]</i> Date Considered: <i>5-12-04</i>		
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